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FDT86246 N-Channel Power Trench[®] MOSFET 150 V, 2 A, 236 m Ω

Features

- Max $r_{DS(on)}$ = 236 m Ω at V_{GS} = 10 V, I_D = 2 A
- Max $r_{DS(on)}$ = 329 m Ω at V_{GS} = 6 V, I_D = 1.7 A
- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability in a widely used surface mount package
- Fast switching speed
- 100% UIL Tested
- RoHS Compliant



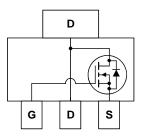
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench[®] process that has been optimized for $r_{DS(on)}$, switching performance and ruggedness.

Applications

- Load Switch
- Primary Switch





MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

| Symbol | Parameter | | Ratings | Units | |
|-----------------------------------|--|-----------|-------------|-------|--|
| V _{DS} | Drain to Source Voltage | | 150 | V | |
| V _{GS} | Gate to Source Voltage | | ±20 | V | |
| I _D | Drain Current -Continuous | (Note 1a) | 2 | | |
| | -Pulsed | | 8 | — A | |
| E _{AS} | Single Pulse Avalanche Energy | (Note 3) | 8 | mJ | |
| P _D | Power Dissipation | (Note 1a) | 2.2 | | |
| | Power Dissipation | (Note 1b) | 1.0 | | |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -55 to +150 | °C | |

Thermal Characteristics

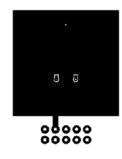
| R_{\thetaJC} | Thermal Resistance, Junction to Case | (Note 1) | 12 | °C/W |
|-----------------|---|-----------|----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1a) | 55 | 0/11 |

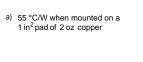
Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|----------|---------|-----------|------------|------------|
| 86246 | FDT86246 | SOT-223 | 13 " | 12 mm | 2500 units |

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units | |
|--|---|---|-----|--|---|---|--|
| Off Chara | acteristics | | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | I _D = 250 μA, V _{GS} = 0 V | 150 | | | V | |
| ΔBV_{DSS} ΔT_J | Breakdown Voltage Temperature Coefficient | $I_D = 250 \ \mu$ A, referenced to 25 °C | | 104 | | mV/°C | |
| IDSS | Zero Gate Voltage Drain Current | V _{DS} = 120 V, V _{GS} = 0 V | | | 1 | μA | |
| I _{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ±100 | nA | |
| On Chara | acteristics | | | | | | |
| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}$, $I_D = 250 \ \mu A$ | 2.0 | 3.1 | 4.0 | V | |
| $\Delta V_{GS(th)}$ ΔT_J | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250 \ \mu$ A, referenced to 25 °C | | -9 | | mV/°C | |
| | Static Drain to Source On Resistance | V _{GS} = 10 V, I _D = 2 A | | 194 | 236 | | |
| r _{DS(on)} | | V _{GS} = 6 V, I _D = 1.7 A | | 231 | 329 | mΩ | |
| | | $V_{GS} = 10 \text{ V}, \ I_D = 2 \text{ A}, \ T_J = 125 \text{ °C}$ | | 349 | 425 | | |
| 9 _{FS} | Forward Transconductance | $V_{DS} = 10 \text{ V}, \ I_D = 2 \text{ A}$ | | 5 | | S | |
| Dynamic | Characteristics | | | | | | |
| | | | | | | | |
| - | Input Capacitance | | | 161 | 215 | pF | |
| C _{iss} | | $V_{DS} = 75 V, V_{GS} = 0 V,$ | | 161 21 | 215 30 | pF pF | |
| C _{iss} C _{oss} | Input Capacitance | V _{DS} = 75 V, V _{GS} = 0 V, f = 1 MHz | | - | - | | |
| C _{iss} C _{oss} C _{rss} | Input Capacitance Output Capacitance | | | 21 | 30 | pF | |
| C _{iss} C _{oss} C _{rss} R _g | Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance | | | 21 1.6 | 30 | pF pF | |
| C _{iss} C _{oss} C _{rss} R _g Switching | Input Capacitance Output Capacitance Reverse Transfer Capacitance | | | 21 1.6 | 30 | pF pF | |
| C _{iss} C _{oss} C _{rss} R _g Switching | Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics | f = 1 MHz | | 21 1.6 0.9 | 30 5 | pF pF Ω | |
| C _{iss} C _{oss} C _{rss} R _g Switching t _{d(on)} | Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time | | | 21 1.6 0.9 7.8 | 30 5 16 | pF pF Ω ns | |
| C_{iss} C_{oss} C_{rss} R_g Switching $t_{d(on)}$ t_r $t_{d(off)}$ | Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time | $ f = 1 \text{ MHz} $ $ V_{DD} = 75 \text{ V, } I_D = 2 \text{ A,} $ $ V_{GS} = 10 \text{ V, } R_{GEN} = 6 \Omega $ | | 21 1.6 0.9 7.8 2.3 | 30 5 16 10 | pF pF Ω ns ns | |
| $\begin{array}{c} C_{iss} \\ C_{oss} \\ C_{rss} \\ R_g \\ \hline \\ Switching \\ t_{d(on)} \\ t_r \\ t_r \\ t_{d(off)} \\ t_f \\ \end{array}$ | Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time | $ f = 1 \text{ MHz} $ $ V_{DD} = 75 \text{ V, } I_D = 2 \text{ A,} $ $ V_{GS} = 10 \text{ V, } R_{GEN} = 6 \Omega $ | | 21 1.6 0.9 7.8 2.3 4.6 | 30 5 16 10 10 | pF pF Ω ns ns ns | |
| $\begin{array}{c} C_{iss} \\ C_{oss} \\ C_{rss} \\ R_g \\ \hline \\ Switching \\ t_{d(on)} \\ t_r \\ t_r \\ t_{d(off)} \\ t_f \\ Q_{g(TOT)} \\ \end{array}$ | Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time | $ f = 1 \text{ MHz} $ $ V_{DD} = 75 \text{ V, } I_D = 2 \text{ A,} $ $ V_{GS} = 10 \text{ V, } R_{GEN} = 6 \Omega $ | | 21 1.6 0.9 7.8 2.3 4.6 1.2 | 30 5 16 10 10 10 | pF pF Ω ns ns ns ns | |
| C _{iss} C _{oss} C _{rss} R g Switching $t_{d(on)}$ t_r $t_{d(off)}$ t_f $Q_{g(TOT)}$ | Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge | f = 1 MHz | | 21 1.6 0.9 7.8 2.3 4.6 1.2 2.9 | 30 5 16 10 10 10 4 | pF pF Ω ns ns ns ns | |
| $\begin{array}{c} C_{iss} \\ C_{oss} \\ C_{rss} \\ R_g \\ \hline \\ \textbf{Switching} \\ \hline \\ \textbf{t}_{d(on)} \\ t_r \\ \hline \\ t_{d(off)} \\ t_f \\ Q_{g(TOT)} \\ Q_{g(TOT)} \\ Q_{gs} \\ \end{array}$ | Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge | $ f = 1 \text{ MHz} $ $ V_{DD} = 75 \text{ V, } I_D = 2 \text{ A,} $ $ V_{GS} = 10 \text{ V, } R_{GEN} = 6 \Omega $ | | 21 1.6 0.9 7.8 2.3 4.6 1.2 2.9 1.7 | 30 5 16 10 10 10 4 | pF pF Ω ns ns ns nc | |
| $\begin{array}{c} C_{iss} \\ \hline C_{oss} \\ \hline C_{rss} \\ \hline R_g \\ \hline \textbf{Switching} \\ \hline \textbf{Switching} \\ \hline \textbf{t}_{d(on)} \\ \hline t_r \\ \hline t_{d(off)} \\ \hline t_f \\ \hline \textbf{Q}_{g(TOT)} \\ \hline \textbf{Q}_{g(TOT)} \\ \hline \textbf{Q}_{gs} \\ \hline \textbf{Q}_{gd} \\ \hline \end{array}$ | Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Total Gate Charge Total Gate Charge | $ f = 1 \text{ MHz} $ $ V_{DD} = 75 \text{ V, } I_D = 2 \text{ A,} $ $ V_{GS} = 10 \text{ V, } R_{GEN} = 6 \Omega $ | | 21 1.6 0.9 7.8 2.3 4.6 1.2 2.9 1.7 0.9 | 30 5 16 10 10 10 4 | pF pF Ω ns ns ns nc nC | |
| $\begin{array}{c} C_{iss} \\ \hline C_{oss} \\ \hline C_{rss} \\ \hline R_g \\ \hline \textbf{Switching} \\ \hline \textbf{Switching} \\ \hline \textbf{t}_{d(on)} \\ \hline t_r \\ \hline t_{d(off)} \\ \hline t_f \\ \hline \textbf{Q}_{g(TOT)} \\ \hline \textbf{Q}_{g(TOT)} \\ \hline \textbf{Q}_{gs} \\ \hline \textbf{Q}_{gd} \\ \hline \hline \textbf{Drain-Sol} \end{array}$ | Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Drain "Miller" Charge | $ f = 1 \text{ MHz} $ $ V_{DD} = 75 \text{ V, } I_D = 2 \text{ A,} $ $ V_{GS} = 10 \text{ V, } R_{GEN} = 6 \Omega $ | | 21 1.6 0.9 7.8 2.3 4.6 1.2 2.9 1.7 0.9 | 30 5 16 10 10 10 4 | pF pF Ω ns ns ns nc nC | |
| $\begin{array}{c} C_{iss} \\ C_{oss} \\ C_{rss} \\ R_g \\ \hline \\ \textbf{Switching} \\ \hline \\ \textbf{t}_{d(on)} \\ \textbf{t}_r \\ \textbf{t}_{d(off)} \\ \textbf{t}_f \\ \hline \\ \textbf{Q}_{g(TOT)} \\ \hline \\ \textbf{Q}_{g(TOT)} \\ \hline \\ \textbf{Q}_{gs} \\ \hline \\ \textbf{Q}_{gd} \\ \hline \end{array}$ | Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance g Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Drain "Miller" Charge urce Diode Characteristics | $ \begin{array}{c} f = 1 \text{ MHz} \\ \\ \hline \\ V_{DD} = 75 \text{ V}, \text{ I}_{D} = 2 \text{ A}, \\ \\ V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega \\ \\ \hline \\ V_{GS} = 0 \text{ V to } 10 \text{ V} \\ \\ V_{GS} = 0 \text{ V to } 5 \text{ V} \\ \\ \hline \\ I_{D} = 2 \text{ A} \end{array} $ | | 21 1.6 0.9 7.8 2.3 4.6 1.2 2.9 1.7 0.9 0.8 | 30 5 16 10 10 10 4 3 | pF pF Ω ns ns ns nc nC nC | |

1. R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.





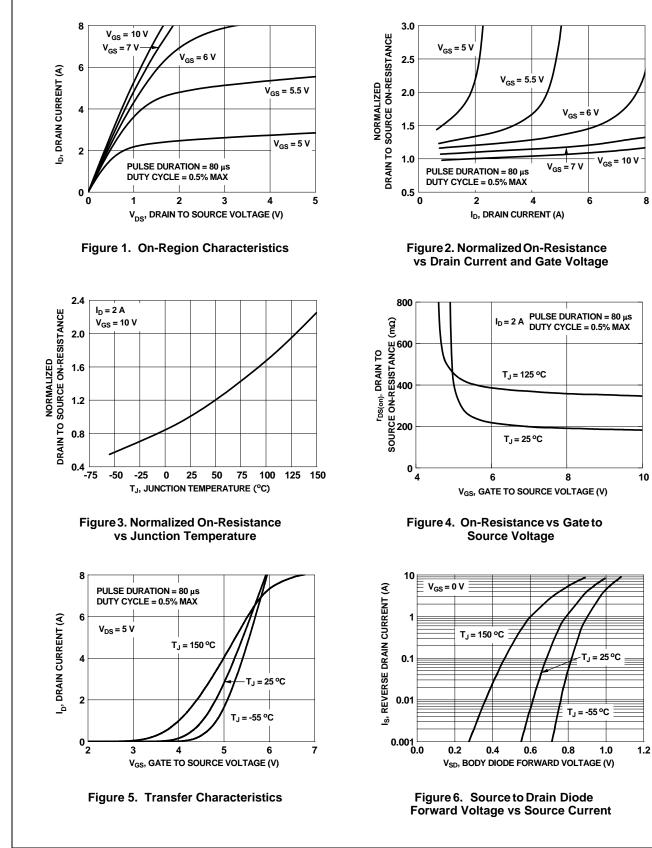


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b) 118 °C/W when mounted on a minimum pad of 2 oz copper

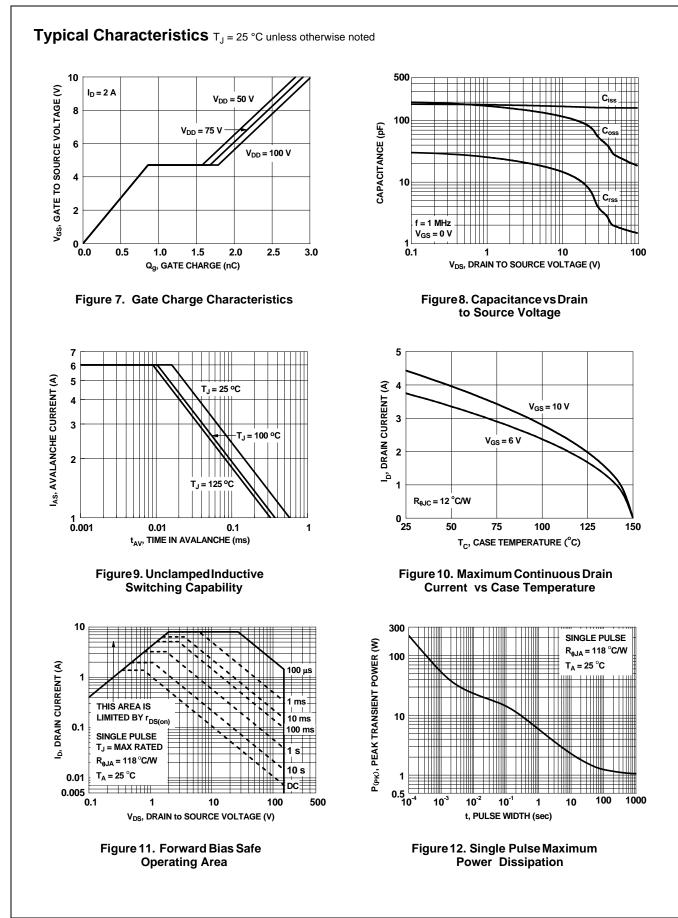
2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.

3. Starting T_J = 25 °C; N-ch: L = 1.0 mH, I_{AS} = 4.0 A, V_{DD} = 135 V, V_{GS} = 10 V.



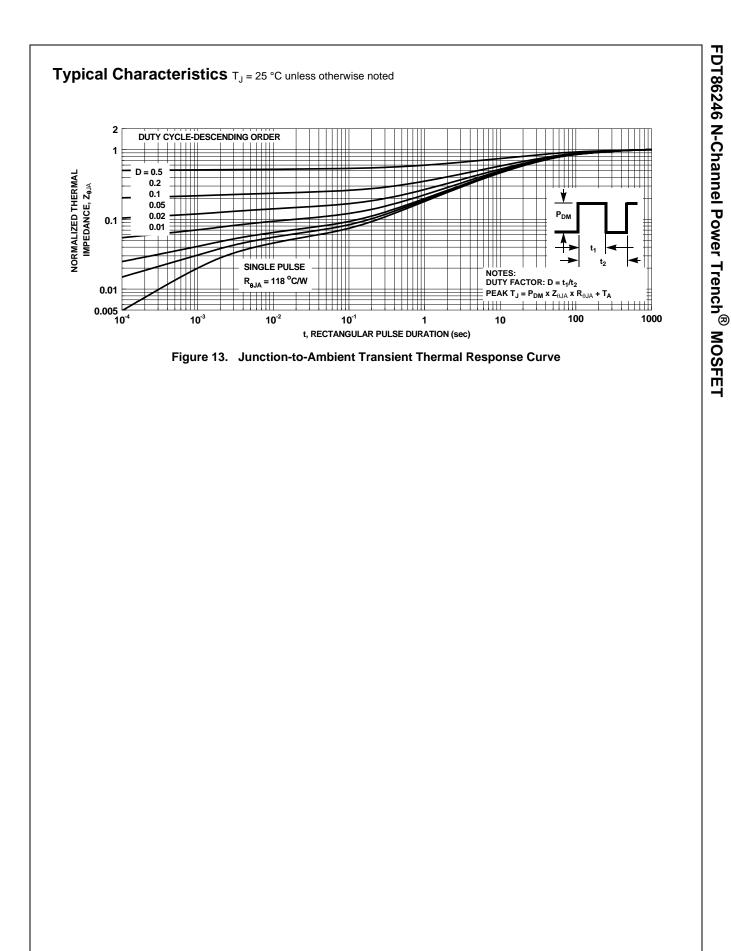
Typical Characteristics T_J = 25 °C unless otherwise noted

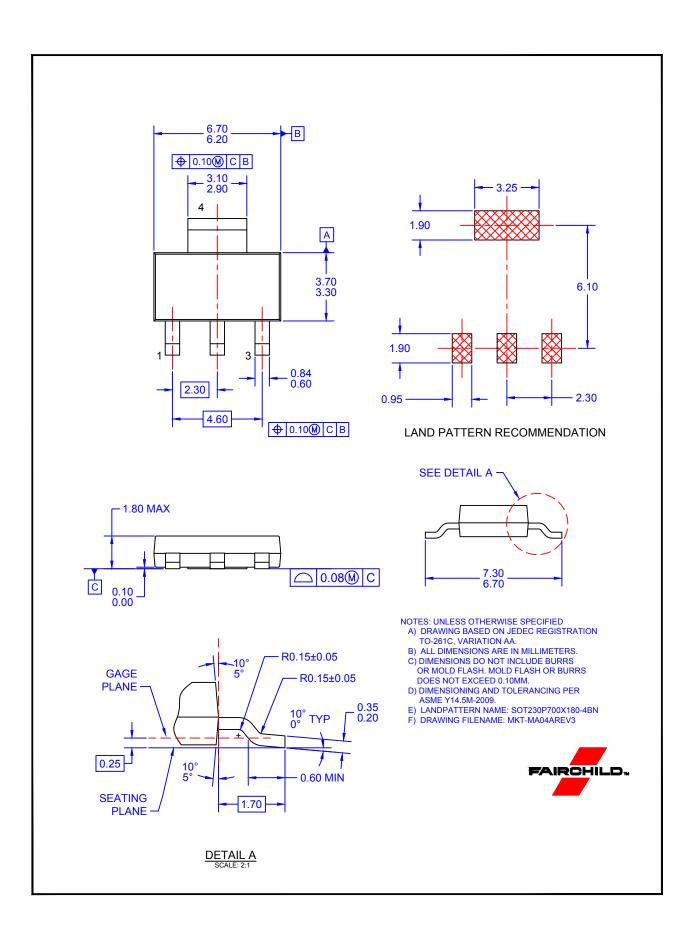
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